802.3ch channel performance at different temperatures

Return Loss, Insertion Loss and investigation of limit line proposals

Josef Ohni (MD Elektronik) May 24, 2018

Supporters: Ricky Vernickel - Leoni

Motivation and Agenda

Motivation

- Supply current Channel measurements at different temperatures
- Investigation of the Insertion limit line at lower frequencies
- Comparing different IL limit line proposals

Agenda

- Test setup and DUT explanation
- Return loss at three different temperatures
- Insertion loss at three different temperatures
- Investigation of IL limit line
- Conclusion

Test setup and DUT

- Shielded Parallel Pair (SPP) Cable
 0.14mm²
 AWG 26
- Channel measurement including the test fixtures on both sides
- Measuring at following temperatures: -40°C, +23°C and +105°C in a climatic chamber



Return Loss at three different temperatures



- Return loss meets the limit line • at all three temperatures
- Margin is large enough •





Insertion Loss at three different temperatures



- Violation of the current limit line at the lower frequencies (black rectangle)
- Insertion loss meets only the limit line proposals at all three temperatures

$\begin{split} & \text{IEEE 802.3ch} (\text{Current limit}) \\ & * \text{Farjad_3ch_01b_0118.pdf} \\ & \text{IL}_{\text{DB}} \; (\text{f}) \leq \textbf{0.003*}\text{f} + \textbf{0.4*} \sqrt{f} \text{ with f in MHz; } 5 \leq \text{f} \leq 5500 \end{split}$
New Limit (proposal) TE *Bergner_DiBiaso_Mandel_3ch_01_0418.pdf IL_{DB} (f) \leq 0.0031*f + 0.3* \sqrt{f} + 1.5 with f in MHz; 5 \leq f \leq 5500
New Limit (proposal) RT *mueller_3ch_01_0318.pdf IL_{DB} (f) \leq 0.003*f + 0.4*\fr + 0.5 with f in MHz; 5 \leq f \leq 5500

4 m

IL limit line investigation at lower frequencies



$$\begin{split} \text{IEEE 802.3ch} & (\text{Current limit}) \\ \text{*Farjad_3ch_01b_0118.pdf} \\ \text{IL}_{\text{DB}} & (\text{f}) \leq \textbf{0.003^*f} + \textbf{0.4^*} \sqrt{f} & \text{with f in MHz; } 5 \leq \text{f} \leq 5500 \\ \\ \text{New Limit (proposal) TE} \\ \text{*Bergner_DiBiaso_Mandel_3ch_01_0418.pdf} \\ \text{IL}_{\text{DB}} & (\text{f}) \leq \textbf{0.0031^*f} + \textbf{0.3^*} \sqrt{f} + \textbf{1.5} & \text{with f in MHz; } 5 \leq \text{f} \leq 5500 \\ \\ \text{New Limit (proposal) RT} \\ \text{*mueller_3ch_01_0318.pdf} \\ \text{IL}_{\text{DB}} & (\text{f}) \leq \textbf{0.003^*f} + \textbf{0.4^*} \sqrt{f} + \textbf{0.5} & \text{with f in MHz; } 5 \leq \text{f} \leq 5500 \\ \end{split}$$

Current Limit is violated at lower frequencies <0.2 GHz The problem is also shown by *mueller_3ch_01_0318.pdf

2 New limit line (proposal) TE have a small margin at frequencies of 0.6 GHz ±0.2 GHz Insertion loss meets both new limit line proposals of RT and TE at all three temperatures

Conclusion

- The insertion loss have a low temperature dependency Approximately 3-4 dB @ 5.5 GHz
- The return loss have **no** temperature dependency
- The IEEE 802.3 channel (1m-1m-1m-8m-4m) with the SPP cables (AWG 26, 0.14mm²)
 - Doesn't fulfill the current insertion loss limit line
 - Fulfills the two insertion loss limit line proposals from
 - RT *mueller_3ch_01_0318.pdf
 - TE *Bergner_DiBiaso_Mandel_3ch_01_0418.pdf

at room temperature (+23°C), -40°C and +105°C